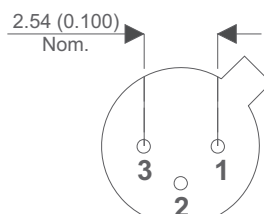
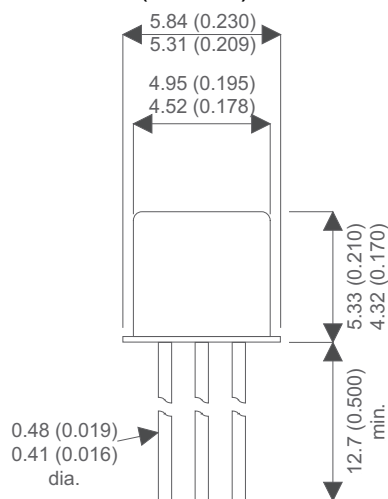


**MECHANICAL DATA**

Dimensions in mm (inches)



**TO-18 (TO-206AA)**

**Underside View**

PAD 1 – Base    PAD 2 – Emitter    PAD 3 – Collector

**ABSOLUTE MAXIMUM RATINGS** ( $T_A = 25^\circ\text{C}$  unless otherwise stated)

$V_{CBO}$	Collector – Base Voltage	40V
$V_{CEO}$	Collector – Emitter Voltage	15V
$V_{EBO}$	Emitter – Base Voltage	4.5V
$I_C$	Collector Current	200mA
$P_D$	Total Device Dissipation @ $T_A = 25^\circ\text{C}$	360mW
	Derate above $25^\circ\text{C}$	2.06mW / $^\circ\text{C}$
$P_D$	Total Device Dissipation @ $T_C = 25^\circ\text{C}$	680mW
	Derate above $25^\circ\text{C}$	6.85mW / $^\circ\text{C}$
$T_{STG}, T_J$	Operating and Storage Temperature Range	$-65$ to $+200^\circ\text{C}$
$R_{\theta_{JC}}$	Thermal Resistance Junction-Case	146 $^\circ\text{C}/\text{W}$
$R_{\theta_{JA}}$	Thermal Resistance Junction-Ambient	486 $^\circ\text{C}/\text{W}$

Semelab Plc reserves the right to change test conditions, parameter limits and package dimensions without notice. Information furnished by Semelab is believed to be both accurate and reliable at the time of going to press. However Semelab assumes no responsibility for any errors or omissions discovered in its use. Semelab encourages customers to verify that datasheets are current before placing orders.

**HIGH SPEED, MEDIUM POWER, NPN SWITCHING TRANSISTOR IN A HERMETICALLY SEALED TO-18 PACKAGE FOR HIGH RELIABILITY APPLICATIONS**

**FEATURES**

- SILICON PLANAR EPITAXIAL NPN TRANSISTOR
- HERMETIC TO18 PACKAGE
- CECC SCREENING OPTIONS

**ELECTRICAL CHARACTERISTICS** ( $T_A = 25^\circ\text{C}$  unless otherwise stated)

Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$V_{(BR)CEO}^*$ Collector – Emitter Breakdown Voltage	$I_C = 10\text{mA}$	15			V
$V_{(BR)CBO}$ Collector – Base Breakdown Voltage	$I_C = 10\mu\text{A}$	40			V
$V_{(BR)EBO}$ Emitter – Base Breakdown Voltage	$I_E = 10\mu\text{A}$	4.5			V
$I_{CES}$ Collector – Emitter Cut-off Current	$V_{CE} = 20\text{V}$			0.40	$\mu\text{A}$
$I_{CBO}$ Collector – Base Cut-off Current	$V_{CB} = 20\text{V}$ $T_A = +150^\circ\text{C}$			30	$\mu\text{A}$
$V_{CE(sat)}^*$ Collector – Emitter Saturation Voltage	$I_C = 10\text{mA}$ $I_B = 1\text{mA}$			0.20	V
		$T_A = +125^\circ\text{C}$		0.30	
	$I_C = 30\text{mA}$ $I_B = 3\text{mA}$			0.25	
	$I_C = 100\text{mA}$ $I_B = 10\text{mA}$			0.5	
$V_{BE(sat)}^*$ Base – Emitter Saturation Voltage	$I_C = 10\text{mA}$ $I_B = 1\text{mA}$	0.70	0.8	0.85	V
		$I_C = 30\text{mA}$ $I_B = 3\text{mA}$		0.9	
	$I_C = 100\text{mA}$ $I_B = 10\text{mA}$		1.1	1.6	
	$I_C = 10\text{mA}$ $I_B = 1\text{mA}$ $T_A = -55^\circ\text{C to } +125^\circ\text{C}$	0.59		1.02	
$h_{FE}^*$ DC Current Gain	$I_C = 10\text{mA}$ $V_{CE} = 0.35\text{V}$	40		120	—
		$I_C = 10\text{mA}$ $V_{CE} = 1\text{V}$	40		
	$I_C = 30\text{mA}$ $V_{CE} = 0.40\text{V}$	30	71		
	$I_C = 100\text{mA}$ $V_{CE} = 1\text{V}$	20			
	$I_C = 10\text{mA}$ $V_{CE} = 0.35\text{V}$ $T_A = -55^\circ\text{C}$	20	50		
$f_T$ Transition Frequency	$I_C = 10\text{mA}$ $V_{CE} = 10\text{V}$ $f = 100\text{MHz}$	500	675		MHz
$C_{cbo}$ Output Capacitance	$I_E = 0$ $V_{CB} = 5\text{V}$ $f = 1\text{MHz}$		2.3	4	pF
$t_s$ Storage Time	$I_C = 10\text{mA}$ $V_{CC} = 10\text{V}$ $I_{B1} = -I_{B2} = 10\text{mA}$		6	13	ns
$t_{on}$ Turn-On Time	$I_C = 10\text{mA}$ $V_{CC} = 3\text{V}$		9	12	ns
$t_{off}$ Turn-Off Time	$I_{B1} = 3\text{mA}$ $I_{B2} = -1.5\text{mA}$		13	18	

\* Pulse Test:  $t_p \leq 300\mu\text{s}$ ,  $\delta \leq 2\%$ .